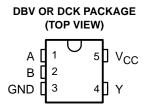
SCLS317K - MARCH 1996 - REVISED JANUARY 2003

- Operating Range of 2 V to 5.5 V
- Max t_{pd} of 6.5 ns at 5 V
- Low Power Consumption, 10-μA Max I_{CC}
- ±8-mA Output Drive at 5 V
- Latch-Up Performance Exceeds 250 mA Per JESD 17



description/ordering information

The SN74AHC1G32 is a single 2-input positive-OR gate. The device performs the Boolean function Y = A + B or $Y = \overline{A \bullet B}$ in positive logic.

ORDERING INFORMATION

TA	PACKAGE	<u></u> †	ORDERABLE PART NUMBER	TOP-SIDE MARKING [‡]
	SOT (SOT-23) – DBV	Reel of 3000	SN74AHC1G32DBVR	A32
	301 (301-23) – DBV	Reel of 250	SN74AHC1G32DBVT	A32_
-40°C to 85°C	SOT (SC-70) – DCK		SN74AHC1G32DCKR	AC
	301 (30-70) - DCK	Reel of 250	SN74AHC1G32DCKT	AG_

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

ĺ	INP	JTS	OUTPUT
I	Α	В	Υ
I	Н	Χ	Н
ı	Χ	Н	Н
I	L	L	L

logic diagram (positive logic)





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



[‡] The actual top-side marking has one additional character that designates the assembly/test site.

SCLS317K - MARCH 1996 - REVISED JANUARY 2003

absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to 7 V
Output voltage range, V _O (see Note 1)	–0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0)	–20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ_{JA} (see Note 2): DBV package	206°C/W
DCK package	252°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 3)

			MIN	MAX	UNIT	
Vcc	Supply voltage		2	5.5	V	
		V _{CC} = 2 V	1.5			
V_{IH}	High-level input voltage	V _{CC} = 3 V	2.1		V	
	V _{CC} = 5.5 V		3.85			
		V _{CC} = 2 V		0.5		
V_{IL}	Low-level input voltage V _{CC} = 3 V		0.9	V		
	V _{CC} = 5.5 V			1.65		
VI	Input voltage		0	5.5	V	
٧o	Output voltage		0	VCC	V	
		V _{CC} = 2 V		-50	μΑ	
IOH	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4	mA	
		$V_{CC} = 5 V \pm 0.5 V$		-8	IIIA	
		V _{CC} = 2 V		50	μΑ	
IOL	Low-level output current $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$			4	mA	
		$V_{CC} = 5 V \pm 0.5 V$		8	IIIA	
A+/A>c	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100	20/1/	
Δt/Δv	nput transition rise or fall rate $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$			20	ns/V	
TA	Operating free-air temperature		-40	85	°C	

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.

SCLS317K - MARCH 1996 - REVISED JANUARY 2003

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vec	T _A = 25°C			MIN	MAV	UNIT	
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	IVIIIV	MAX	UNII	
		2 V	1.9	2		1.9			
	I _{OH} = -50 μA	3 V	2.9	3		2.9			
V _{OH}		4.5 V	4.4	4.5		4.4		V	
	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48			
	$I_{OH} = -8 \text{ mA}$	4.5 V	3.94			3.8			
		2 V			0.1		0.1		
	I _{OL} = 50 μA	3 V			0.1		0.1		
VOL		4.5 V			0.1		0.1	V	
	I _{OL} = 4 mA	3 V			0.36		0.44		
	I _{OL} = 8 mA	4.5 V			0.36		0.44		
Ι _Ι	V _I = 5.5 V or GND	0 V to 5.5 V			±0.1		±1	μΑ	
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			1		10	μΑ	
C _i	$V_I = V_{CC}$ or GND	5 V		2	10		10	pF	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T	λ = 25°C	;	MIN	MAX	UNIT										
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIN	WAX											
^t PLH	A or B Y C _L = 15	V	V 0 45 75		5.5	7.9	1	9.5	no										
^t PHL		1	'	1	'	'	'	'	1	'	CL = 15 pF	CL = 15 pr	OL = 15 pr	CL = 15 pr		5.5	7.9	1	9.5
^t PLH	A == D	v	C: - 50 pF		8	11.4	1	13	no										
^t PHL	A or B	ī	C _L = 50 pF		8	11.4	1	13	ns										

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

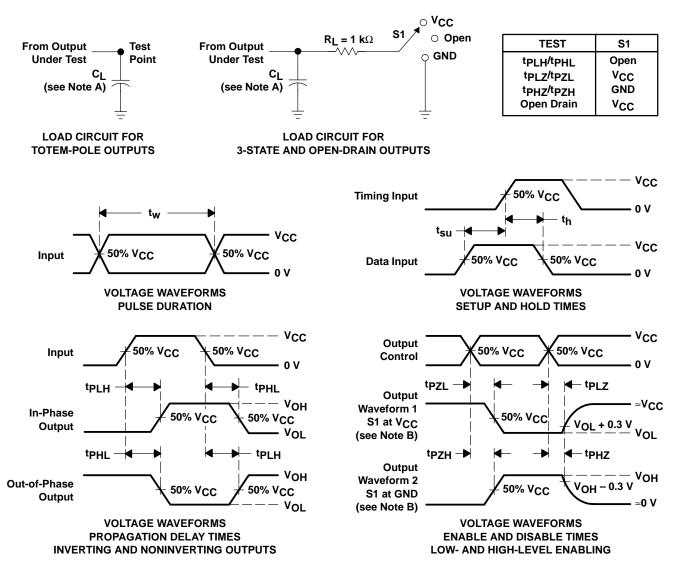
PARAMETER	FROM	TO LOAD		T _A = 25°C			MIN	MAX	UNIT	
PARAWETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIN	IVIAA	UNIT	
tPLH	A or B	V	v	C _I = 15 pF		3.8	5.5	1	6.5	ns
t _{PHL}	AOIB	·	Γ CL = 13 pi		3.8	5.5	1	6.5	115	
^t PLH	A or B	V	C _I = 50 pF		5.3	7.5	1	8.5	ns	
^t PHL	AOIB	ı	OL = 30 pr		5.3	7.5	1	8.5	115	

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER		ONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	14	pF



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f \leq 3$ ns. $t_f \leq 3$ ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third—party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Mailing Address:

Texas Instruments
Post Office Box 655303
Dallas, Texas 75265

Copyright © 2003, Texas Instruments Incorporated